## Notice of References Cited Application/Control No. 10/815,881 Examiner Tae H. Yoon Applicant(s)/Patent Under Reexamination ALGER ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,262,476	11-1993	Laughner, Michael K.	525/67
*	В	US-5,270,386	12-1993	Laughner, Michael K.	525/66
*	C	US-6,350,804	02-2002	Adedeji et al.	524/445
*	D	US-6,353,050	03-2002	Bastiaens et al.	524/538
*	E.	US-6,352,654	03-2002	Silvi et al.	252/511
*	F	US-6,627,701	09-2003	Adedeji et al.	525/68
*	G	US-6,908,964	06-2005	Adedeji et al.	525/68
	I	US-			
	1	US-			
	۲	US-			
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N		•			
	0	`				
	Р					
	a					•
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	ט					
	٧					
	>					
	×					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.